## **Power MOSFET**

## -20 V, -3.0 A, Dual P-Channel ChipFET™

### **Features**

- Low R<sub>DS(on)</sub> for Higher Efficiency
- Logic Level Gate Drive
- Miniature ChipFET Surface Mount Package Saves Board Space
- Pb-Free Package is Available

### **Applications**

• Power Management in Portable and Battery–Powered Products; i.e., Cellular and Cordless Telephones and PCMCIA Cards

### **MAXIMUM RATINGS** (T<sub>A</sub> = 25°C unless otherwise noted)

Rating	Symbol	5 secs	Steady State	Unit
Drain-Source Voltage	V <sub>DS</sub>	-2	20	V
Gate-Source Voltage	V <sub>GS</sub>	±	12	V
Continuous Drain Current (T <sub>J</sub> = 150°C) (Note 1) T <sub>A</sub> = 25°C T <sub>A</sub> = 85°C	I <sub>D</sub>	±3.0 ±2.2	±2.2 ±1.6	А
Pulsed Drain Current	I <sub>DM</sub>	±	10	Α
Continuous Source Current (Diode Conduction) (Note 1)	I <sub>S</sub>	-3.0	-2.2	А
Maximum Power Dissipation (Note 1)  T <sub>A</sub> = 25°C  T <sub>A</sub> = 85°C	P <sub>D</sub>	2.1 1.1	1.1 0.6	W
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	–55 to	+150	°C

Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.

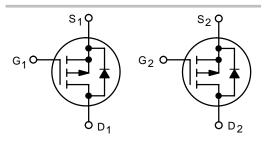
 Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.27 in sq [1 oz] including traces).



### ON Semiconductor®

### http://onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> TYP	I <sub>D</sub> MAX
-20 V	130 mΩ @ –4.5 V	-3.0 A
	215 mΩ @ –2.5 V	0.071



P-Channel MOSFET

P-Channel MOSFET



ChipFET CASE 1206A STYLE 2

#### PIN **MARKING** CONNECTIONS **DIAGRAM** 1 S₁ $D_1$ 8 2 G<sub>1</sub> $D_1$ 2 Ą 3 S<sub>2</sub> $D_2$ 6 3 $\boxed{4}$ $G_2$ $D_2$ 4 **)** 5

A7 = Specific Device Code

M = Month Code

= Pb-Free Package

### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTHD5903T1	ChipFET	3000/Tape & Reel
NTHD5903T1G	ChipFET (Pb-Free)	3000/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

### THERMAL CHARACTERISTICS

Characteristic	Symbol	Тур	Max	Unit
Maximum Junction-to-Ambient (Note 2) t ≤ 5 s Steady State	$R_{ hetaJA}$	50 90	60 110	°C/W
Maximum Junction-to-Foot (Drain) Steady State	$R_{ heta JF}$	30	40	°C/W

<sup>2.</sup> Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.27 in sq [1 oz] including traces).

## **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Characteristic	Symbol	Test Condition	Min	Тур	Max	Unit
Static			•			•
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	-0.6			V
Gate-Body Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 12 \text{ V}$			±100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = -16 \text{ V}, V_{GS} = 0 \text{ V}$			-1.0	μΑ
		$V_{DS} = -16 \text{ V}, V_{GS} = 0 \text{ V},$ $T_{J} = 85^{\circ}\text{C}$			-5.0	
On-State Drain Current (Note 3)	I <sub>D(on)</sub>	$V_{DS} \le -5.0 \text{ V}, V_{GS} = -4.5 \text{ V}$	-10			Α
Drain-Source On-State Resistance (Note 3)	r <sub>DS(on)</sub>	$V_{GS} = -4.5 \text{ V}, I_D = -2.2 \text{ A}$		0.130	0.155	Ω
		$V_{GS} = -3.6 \text{ V}, I_D = -2.0 \text{ A}$		0.150	0.180	
		$V_{GS} = -2.5 \text{ V}, I_D = -1.7 \text{ A}$		0.215	0.260	
Forward Transconductance (Note 3)	9 <sub>fs</sub>	$V_{DS} = -10 \text{ V}, I_{D} = -2.2 \text{ A}$		5.0		S
Diode Forward Voltage (Note 3)	$V_{SD}$	$I_S = -2.2 \text{ A}, V_{GS} = 0 \text{ V}$		-0.8	-1.2	V
Dynamic (Note 4)	•		•	•	•	
Total Gate Charge	Qg			3.7	7.4	nC
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS} = -10 \text{ V}, V_{GS} = -4.5 \text{ V},$ $I_{D} = -2.2 \text{ A}$		0.8		
Gate-Drain Charge	Q <sub>gd</sub>	g =.=.··		1.3		
Turn-On Delay Time	t <sub>d(on)</sub>			13	20	ns
Rise Time	t <sub>r</sub>	$V_{DD} = -10 \text{ V}, R_L = 10 \Omega$		35	55	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong -1.0 \text{ A}, V_{GEN} = -4.5 \text{ V},$ $R_G = 6 \Omega$		25	40	
Fall Time	t <sub>f</sub>	1		25	40	1
Source-Drain Reverse Recovery Time	t <sub>rr</sub>	$I_{\rm F} = -2.2  \text{A},  \text{di/dt} = 100  \text{A/us}$		40	80	1

Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Guaranteed by design, not subject to production testing.

## TYPICAL ELECTRICAL CHARACTERISTICS

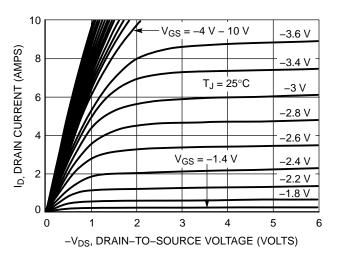


Figure 1. On-Region Characteristics

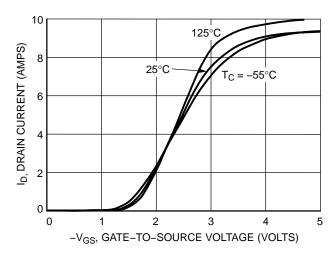


Figure 2. Transfer Characteristics

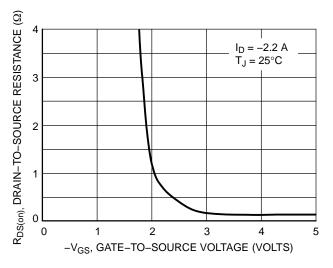


Figure 3. On-Resistance vs. Gate-to-Source Voltage

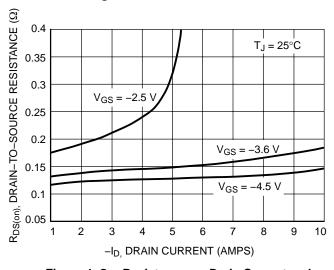


Figure 4. On–Resistance vs. Drain Current and Gate Voltage

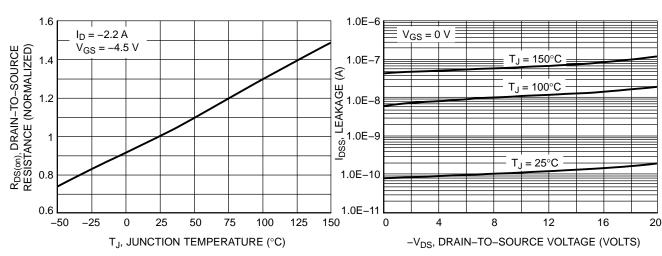
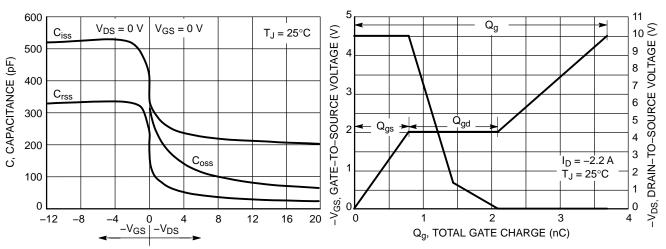


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

### TYPICAL ELECTRICAL CHARACTERISTICS



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (VOLTS)

Figure 7. Capacitance Variation

Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

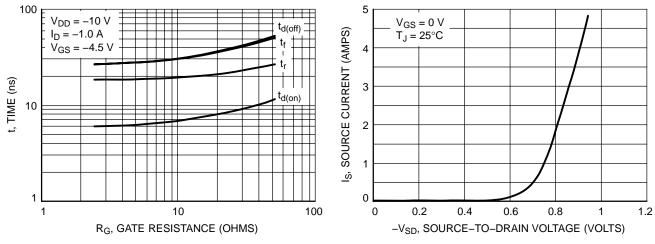


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 10. Diode Forward Voltage vs. Current

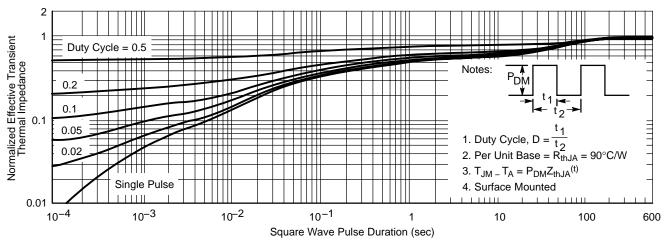
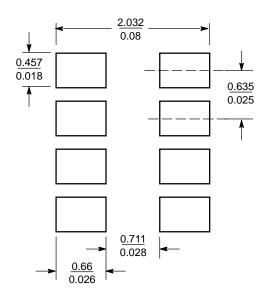


Figure 11. Normalized Thermal Transient Impedance, Junction-to-Ambient

#### **SOLDERING FOOTPRINT\***



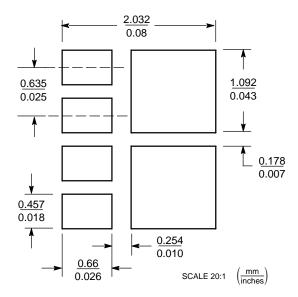


Figure 12. Basic

Figure 13. Style 2

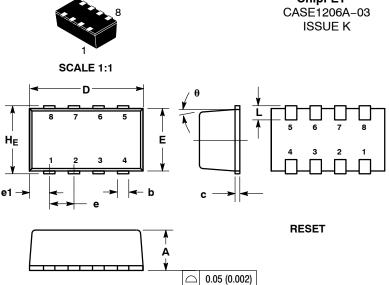
### **BASIC PAD PATTERNS**

The basic pad layout with dimensions is shown in Figure 12. This is sufficient for low power dissipation MOSFET applications, but power semiconductor performance requires a greater copper pad area, particularly for the drain leads.

The minimum recommended pad pattern shown in Figure 13 improves the thermal area of the drain connections (pins 5, 6, 7, 8) while remaining within the

confines of the basic footprint. The drain copper area is 0.0019 sq. in. (or 1.22 sq. mm). This will assist the power dissipation path away from the device (through the copper leadframe) and into the board and exterior chassis (if applicable) for the single device. The addition of a further copper area and/or the addition of vias to other board layers will enhance the performance still further.

<sup>\*</sup>For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.



**ChipFET™** 

**DATE 19 MAY 2009** 

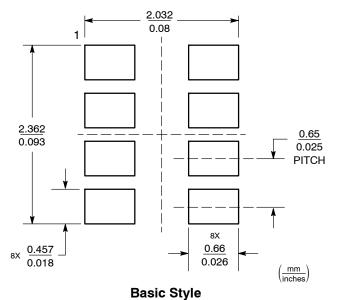
#### NOTES:

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. CONTROLLING DIMENSION: MILLIMETER.
- MOLD GATE BURRS SHALL NOT EXCEED 0.13 MM PER SIDE. LEADFRAME TO MOLDED BODY OFFSET IN HORIZONTAL
- AND VERTICAL SHALL NOT EXCEED 0.08 MM.
  DIMENSIONS A AND B EXCLUSIVE OF MOLD GATE BURRS.
- NO MOLD FLASH ALLOWED ON THE TOP AND BOTTOM LEAD SURFACE.

	MILLIMETERS				INCHES	
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α	1.00	1.05	1.10	0.039	0.041	0.043
b	0.25	0.30	0.35	0.010	0.012	0.014
С	0.10	0.15	0.20	0.004	0.006	0.008
D	2.95	3.05	3.10	0.116	0.120	0.122
E	1.55	1.65	1.70	0.061	0.065	0.067
е	0.65 BSC				0.025 BSC	)
e1		0.55 BSC			0.022 BSC	
L	0.28	0.35	0.42	0.011	0.014	0.017
HE	1.80	1.90	2.00	0.071	0.075	0.079
θ	5° NOM				5° NOM	

STYLE 1:	STYLE 2:	STYLE 3:	STYLE 4:	STYLE 5:	STYLE 6:
PIN 1. DRAIN	PIN 1. SOURCE 1	PIN 1. ANODE	PIN 1. COLLECTOR	PIN 1. ANODE	PIN 1. ANODE
<ol><li>DRAIN</li></ol>	<ol><li>GATE 1</li></ol>	2. ANODE	<ol><li>COLLECTOR</li></ol>	<ol><li>ANODE</li></ol>	2. DRAIN
<ol><li>DRAIN</li></ol>	<ol><li>SOURCE 2</li></ol>	<ol><li>SOURCE</li></ol>	<ol><li>COLLECTOR</li></ol>	<ol><li>DRAIN</li></ol>	3. DRAIN
<ol><li>GATE</li></ol>	4. GATE 2	4. GATE	4. BASE	<ol><li>DRAIN</li></ol>	4. GATE
<ol><li>SOURCE</li></ol>	5. DRAIN 2	5. DRAIN	<ol><li>EMITTER</li></ol>	<ol><li>SOURCE</li></ol>	<ol><li>SOURCE</li></ol>
<ol><li>DRAIN</li></ol>	6. DRAIN 2	6. DRAIN	<ol><li>COLLECTOR</li></ol>	6. GATE	6. DRAIN
7. DRAIN	7. DRAIN 1	<ol><li>CATHODE</li></ol>	<ol><li>COLLECTOR</li></ol>	<ol><li>CATHODE</li></ol>	7. DRAIN
8. DRAIN	8. DRAIN 1	<ol><li>CATHODE</li></ol>	<ol><li>COLLECTOR</li></ol>	<ol><li>CATHODE</li></ol>	8. CATHODE / DRAIN

### **SOLDERING FOOTPRINT**



### **GENERIC MARKING DIAGRAM\***



= Specific Device Code XXX

М = Month Code

= Pb-Free Package

(Note: Microdot may be in either location)

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present.

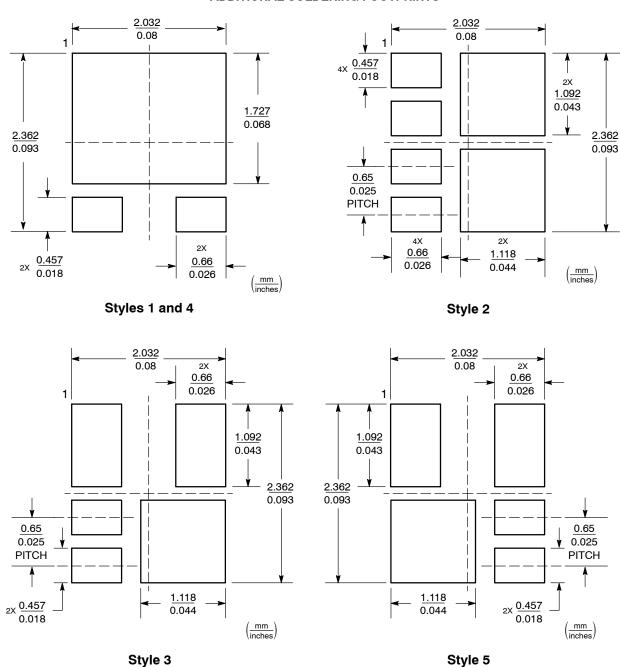
### **OPTIONAL SOLDERING FOOTPRINTS ON PAGE 2**

DOCUMENT NUMBER:	98AON03078D	Electronic versions are uncontrolled except when accessed directly from the Document Reposition Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.	
DESCRIPTION:	ChipFET		PAGE 1 OF 2

ON Semiconductor and un are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. ON Semiconductor does not convey any license under its patent rights nor the

**DATE 19 MAY 2009** 

### **ADDITIONAL SOLDERING FOOTPRINTS\***



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

DOCUMENT NUMBER:	98AON03078D	Electronic versions are uncontrolled except when accessed directly from the Document Repositor Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.	
DESCRIPTION:	ChipFET		PAGE 2 OF 2

ON Semiconductor and are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. ON Semiconductor does not convey any license under its patent rights nor the rights of others.

onsemi, ONSEMI, and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at <a href="www.onsemi.com/site/pdf/Patent-Marking.pdf">www.onsemi.com/site/pdf/Patent-Marking.pdf</a>. Onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using onsemi products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications provided by onsemi. "Typical" parameters which may be provided in onsemi data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. onsemi does not convey any license under any of its intellectual property rights nor the rights of others. onsemi products are not designed, intended, or authorized for use as a critical component in life support systems or any EDA class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer pu

#### **PUBLICATION ORDERING INFORMATION**

LITERATURE FULFILLMENT: Email Requests to: orderlit@onsemi.com

onsemi Website: www.onsemi.com

TECHNICAL SUPPORT North American Technical Support: Voice Mail: 1 800-282-9855 Toll Free USA/Canada Phone: 011 421 33 790 2910

Europe, Middle East and Africa Technical Support:

Phone: 00421 33 790 2910

For additional information, please contact your local Sales Representative